CERTIFICATE OF ACCREDITATION

In terms of section 22(2) (b) of the Accreditation for Conformity Assessment, Calibration and Good Laboratory Practice Act, 2006 (Act 19 of 2006), read with sections 23(1), (2) and (3) of the said Act, I hereby certify that:-

NATIONAL METROLOGY INSTITUTE OF SOUTH AFRICA TIME AND FREQUENCY LABORATORY

Accreditation Number: 1604

is a South African National Accreditation System accredited Calibration Laboratory provided that all SANAS conditions and requirements are complied with

This certificate is valid as per the scope as stated in the accompanying scope of accreditation Annexure "A", bearing the above accreditation number for

TIME AND FREQUENCY METROLOGY

The facility is accredited in accordance with the recognised International Standard

ISO/IEC 17025:2017

The accreditation demonstrates technical competency for a defined scope and the operation of a laboratory quality management system

While this certificate remains valid, the Accredited Facility named above is authorised to use the relevant SANAS accreditation symbol to issue facility reports and/or certificates

Mr T Baleni Acting Chief Executive Officer

Effective Date: 11 February 2022 Certificate Expires: 10 January 2027

ANNEXURE A

SCOPE OF ACCREDITATION

TIME AND FREQUENCY METROLOGY

Accreditation Number: 1604

Permanent Address of Laboratory: National Metrology Institute of SA Time and Frequency Laboratory Building 5, CSIR Campus Meiring Naude Road Brummeria Pretoria 0002		<u>y:</u> <u>Technical Signatorie</u>	Mr C Matthee (all exce Ms M Nel (all exce Mr P Jivan (all exc	Mr C Matthee (all except 3.4.6) Ms M Nel (all except 1) Mr P Jivan (all except 1 & 3.4.6)		
Postal A Private I Lynnwoo 0040	Address: Bag X34 od Ridge	Nominated Represer	ntative: Ms LN Ntatamala			
Tel:	(012) 841-2633	Issue No.:	16			
Fax:	(012) 841-2131	Date of Issue:	11 February 2022			
E-mail:	Intatamala@nmisa.org	Expiry Date:	10 January 2027			
	cmatthee@nmisa.org					
ITEM	MEASURED QUANTITY OR TYPE OF GAUGE OR INSTRUMENT	RANGE OF MEASURED QUANTITY	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	METHOD / PROCEDURE		
1	ТІМЕ					
1.1	Time Scale Difference					
1.1.1	Local clock vs UTC (ZA)	- 1 s to + 1 s	2 ns	Direct measurement between two clocks.		
1.1.2	Local clock vs UTC	- 1 s to + 1 s	8 ns	Post-processed direct time interval measurement.		
2	FREQUENCY					
2.1	Standard Frequency Source					
2.1.1	Local	1 MHz, 5 MHz, 10 MHz	1•10 ⁻¹³ •f	Calibration by phase difference measurement against a reference standard.		
2.2	General Frequency Source					
			2•10 ⁻¹⁰ •f + 10 uHz	Calibration by direct		
2.2.1	General	1,3 GHz to 40 GHz	3 Hz	measurement against a reference standard.		

Original Date of Accreditation: 1 July 2003

The CMC, expressed as an expanded uncertainty of measurement, is stated as the standard uncertainty of measurement multiplied by a coverage factor k = 2, corresponding to a confidence level of approximately 95%

Accreditation Manager

ANNEXURE A

Accreditation No.: 1604 Date of Issue: 11 February 2022 Expiry Date: 10 January 2027

ITEM	MEASURED QUANTITY OR TYPE OF GAUGE OR INSTRUMENT	RANGE OF MEASURED QUANTITY	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	METHOD / PROCEDURE	
2.3	Frequency Meter				
2.3.1	Frequency Counter	1 mHz to 1,3 GHz	2•10 ^{₋10} •f + 10 µHz	Calibration by direct generation using laboratory standard.	
2.3.2	Frequency Meter	1 mHz to 1,3 GHz	2•10 ⁻¹⁰ •f + 10 µHz	Calibration by direct generation using laboratory standard.	
3	TIME INTERVAL SOURCE				
3.1	Period Source				
3.1.1	Period source	1 ns to 1 000 s 1 000 s to 100 000 s	2•10 ⁻¹¹ •t + 200 ps 5•10 ⁻¹⁰ •t	Calibration by direct measurement against a reference standard.	
3.2	Time Interval Source				
3.2.1	Rise and fall time source	15 ps to 1 μs	0,006•t + 6 ps	Time interval measurement or deconvolution method.	
3.2.2	Pulse width	1 ns to 1 000 s 1 000 s to 100 000 s	2•10 ⁻¹¹ •t + 200 ps 5•10 ⁻¹⁰ •t	Direct measurement of the time interval using a reference standard.	
3.2.4	Delay source	1 ns to 1 000 s 1 000 s to 100 000 s	2•10 ⁻¹¹ •t + 200 ps 5•10 ⁻¹⁰ •t	Calibration by direct measurement against laboratory standard.	
3.3	Period Meter				
3.3.1	Period Meter	1 ns to 1 000 s 1 000 s to 100 000 s	2•10 ⁻¹¹ •t + 2 ns 1 ms	Calibration by direct generation or comparison against laboratory standard.	
3.4	Time Interval Meter				
3.4.1	Rise and fall time meter	15 ps to 1 μs	0,006•t + 6 ps	Calibration by direct generation using laboratory standard.	
3.4.2	Pulse width meter	1 ns to 1 000 s	2•10 ⁻¹¹ •t + 2 ns	Calibration by direct generation using laboratory standard.	
3.4.4	Delay meter	1 ns to 1 000 s	2•10 ⁻¹¹ •t + 2 ns	Calibration by direct generation using laboratory standard.	
3.4.6	LIDAR speed meter	0 km/h to 360 km/h (0 m/s to 100 m/s)	0,5 km/h (0,14 m/s)	Calibration by optical speed simulation.	
5	ROTATIONAL SPEED				
5.2	Contact Tachometer	5 rpm to 100 rpm 100 rpm to 1 000 rpm 1 000 rpm to 7 000 rpm	0,01 rpm + 3•10 ⁻⁴ •f 0,1 rpm + 3•10 ⁻⁴ •f 1 rpm + 3•10 ⁻⁴ •f	Calibration using frequency meter and a rotation speed generator.	

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Accreditation Manager

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ITEM	MEASURED QUANTITY OR TYPE OF GAUGE OR INSTRUMENT	RANGE OF MEASURED QUANTITY	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	METHOD / PROCEDURE
5.3	Non-Contact Tachometer (Optical)	5 rpm to 100 rpm 100 rpm to 1 000 rpm 1 000 rpm to 100 000 rpm	0,01 rpm 0,1 rpm 1 rpm	Calibration by optical simulation
5.6	Other rotational devices	5 rpm to 1 000 rpm 1 000 rpm to 100 000 rpm	0,01 rpm + 5•10 ⁻⁴ •f 1 rpm + 5•10 ⁻⁴ •f	Calibration by direct measurement against laboratory standard.
6	PHASE ANGLE			
6.1	Phase angle meter	0 to 360°, 5 V equal amplitude: 1 Hz to 6,25 kHz 6,25 kHz to 50 kHz 50 kHz to 100 kHz 0 to 360°, 50 mV to 100 V: 1 Hz to 100 kHz	0,005° 0,01° 0,02° 0,05°	Direct measurement against a phase standard.

Original date of accreditation: 1 July 2003

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ISSUED BY THE SOUTH AFRICAN NATIONAL ACCREDITATION SYSTEM

Accreditation Manager